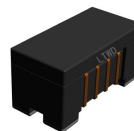


SACT3225A Series Common Mode Line Filter

For high-speed differential signal line,
general differential signal line



◆特征:

- 绕线结构, 体积小
- 低损耗
- 优异的可焊性
- 高频共模阻抗高, 噪声抑制性能优良

- 符合 RoHS, 无卤和 REACH
- 符合 AEC-Q200.

◆用途:

- 个人电脑及外设 USB 线
- IEEE 1394 线用于个人电脑、DVC、STB
- LVDS、液晶面板线、图形卡等
- 适合大电流电路

◆环境:

- 工作温度: -40°C 至 $+150^{\circ}\text{C}$
(包括线圈自身温升)

◆试验设备:

- 电流: HP4284+42841A
- 阻抗: E4991B+ HP16197A 测试夹具
- 直流电阻: Chroma 16502 或同等仪器
- I.R: HP4239B 或同等仪器

◆产品型号:

Features:

- Winding structure and small size
- Low insertion loss at frequency range
Excellent solderability
- High common mode impedance at high frequency effects
excellent noise suppression performance
- RoHS, Halogen Free and REACH Compliance
- AEC-Q200 Compliant.

Applications:

- USB line for personal computers and peripheral
- IEEE 1394 line for personal computers, DVC, STB
- LVDS, panel line for liquid display panels, graph card etc
- Suitable for high current circuit

Environmental Data:

- Operating Temperature: -40°C to $+150^{\circ}\text{C}$
(Including coils self-temperature rise)

Test Equipment:

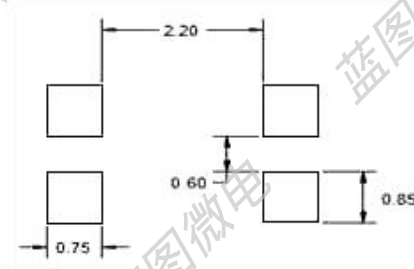
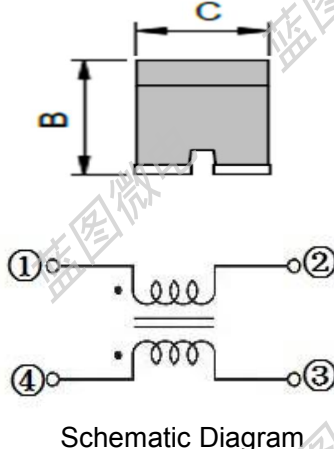
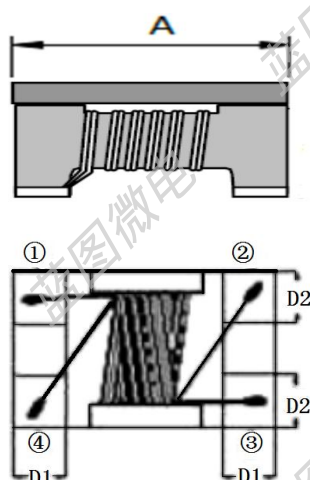
- Isat & Irms: HP4284+42841A
- Impedance: E4991B analyzer with HP16197A test fixture
- DCR: Chroma 16502 or equivalent
- I.R: HP4239B or equivalent

Product Identification:

① SACT		② 3225	③ A	④ 501	⑤ 2P	⑥ I
①		②		③		④
类型 Type		外形尺寸(L×W×H) (mm)		A		⑤
SACT	贴片共模滤波器	External Dimensions (L×W×H)		Automotive		⑥
	SMD Common Mode Line Filter	(mm)				
		3225	3.2×2.2×2.5			
④		⑤		⑥		
Impedance		2P		包装 Packing		
51uH		Double Lines		B	散装 Bulk Package	
				T	编带 Tape & Reel	

◆外观尺寸:

Shape and Dimensions(dimensions are in mm):



Recommended
Land Pattern

Part No	ITEM				
	A	B	C	D1	D2
SACT3225A	3.3±0.2	2.5MAX	2.5±0.2	0.55±0.15	0.75±0.2

◆规格特性:

Specifications:

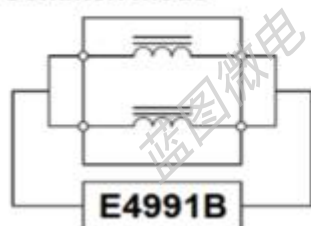
● SACT3225A Series Electrical Characteristics (Electrical specifications at 25℃)

Part Number	Common Mode Impedance Z(Ω)		Test Frequency (MHz)	Inductance(μH) +50/-30% [100kHz/0.1V]	DC Resistance (Ω) Max	Rated Current (mA) Max	Rated Voltage (Vdc) Max	Insulation Resistance (MΩ) Min
	Min	Typ						
SACT3225A-110-2P	300	550	10	11	0.4	300	80	10
SACT3225A-220-2P	500	1100	10	22	0.5	250	80	10
SACT3225A-510-2P	1000	2600	10	51	0.7	200	80	10
SACT3225A-101-2P	2200	5100	10	100	1.5	150	80	10

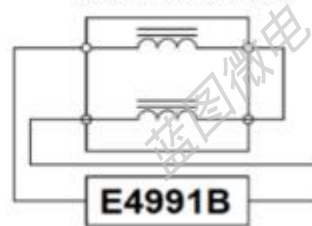
● Rated Current: the actual value of DC current when the temperature rise is ΔT 40℃ (Ta=25℃)

● Circuit: Test Mode

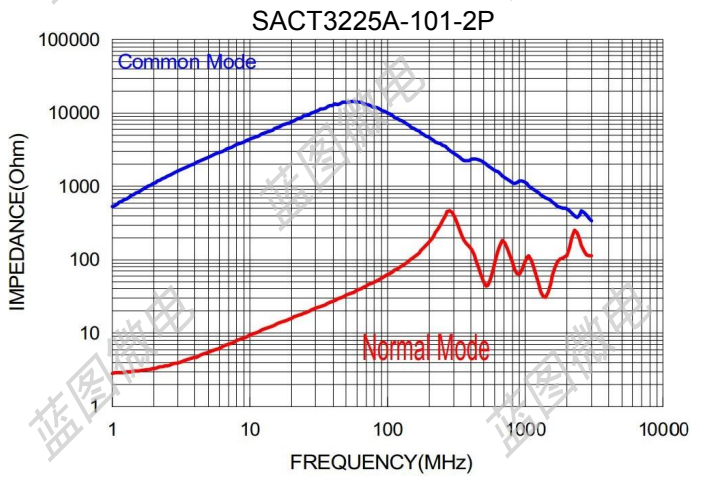
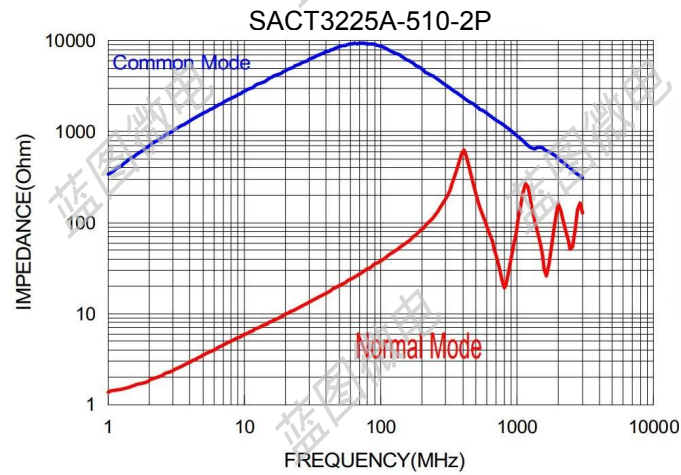
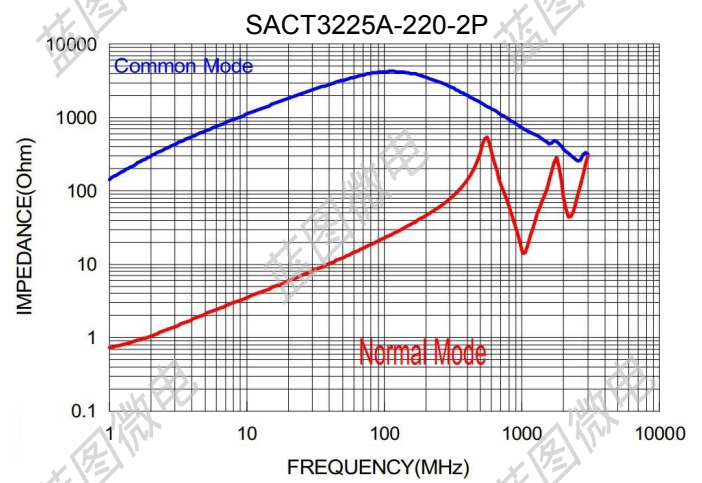
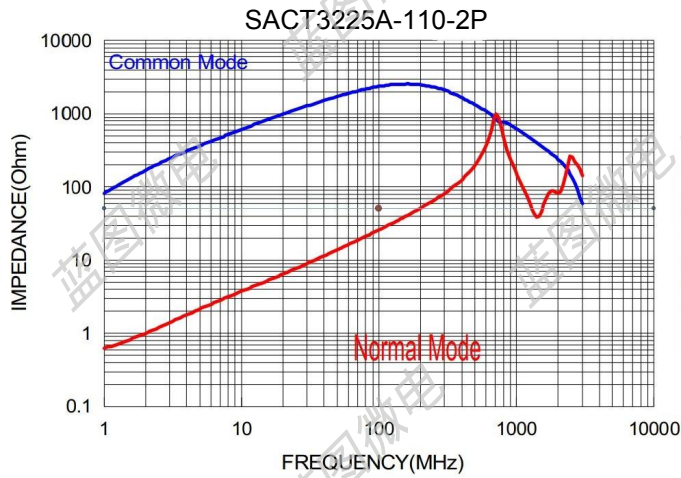
Common mode



Normal mode



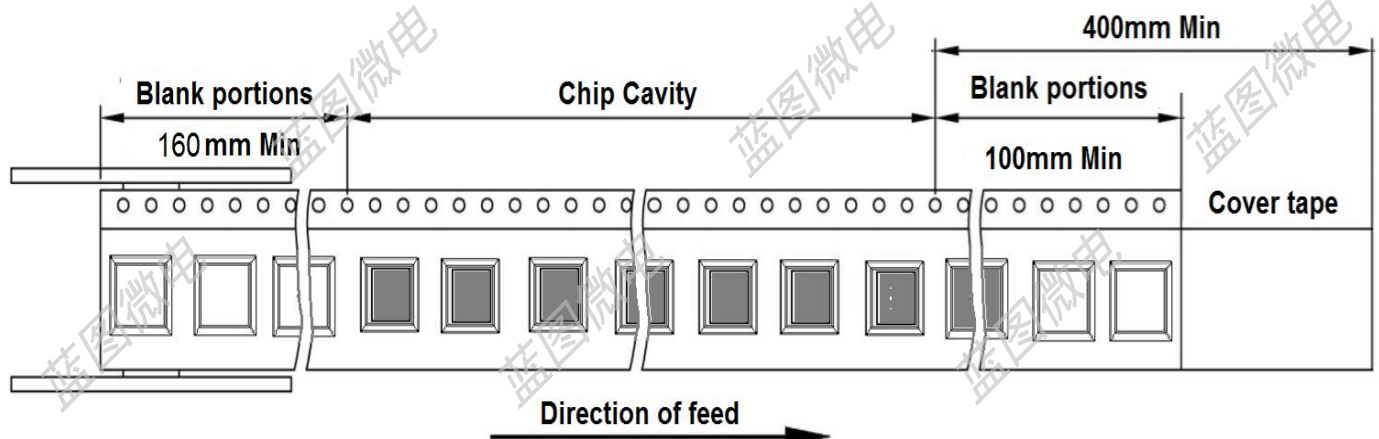
• Typical Impedance versus Frequency



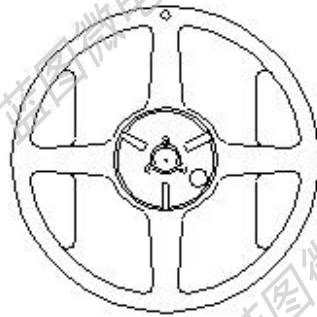
◆ 产品包装:

• Tape and Reel Specifications: (Dimensions are in mm)

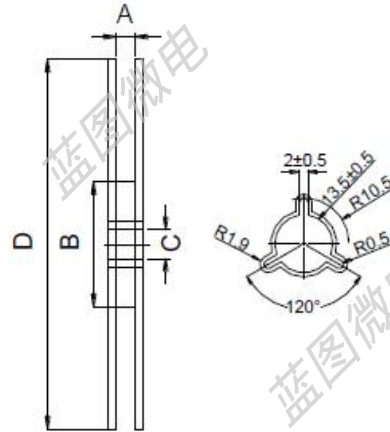
Packaging:



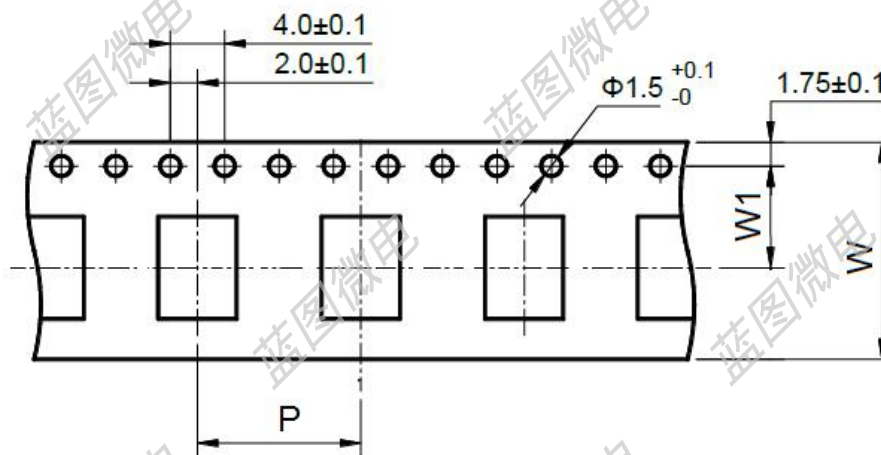
● Reel dimensions (mm)



7"

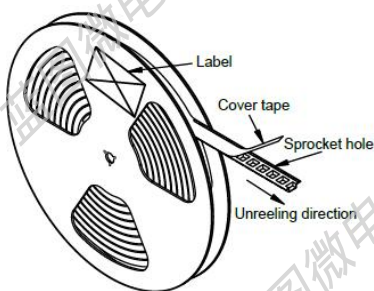


● Tape Dimension (mm)



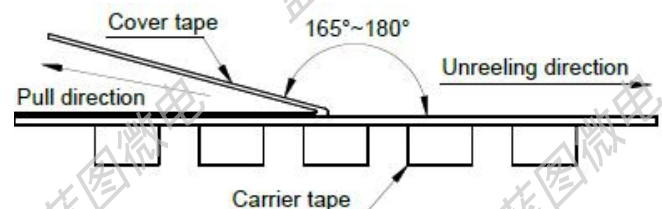
Part No.	Tape Dimension			Reel Dimensions				REEL (PCS)	Inside Box(PCS)	Outside Carton(PCS)
	W	P	W1	A	B	C	D			
SACT3225A	8	4	3.5	8.5	60	13	180	2000	20,000	120,000

● Cover tape peel off condition

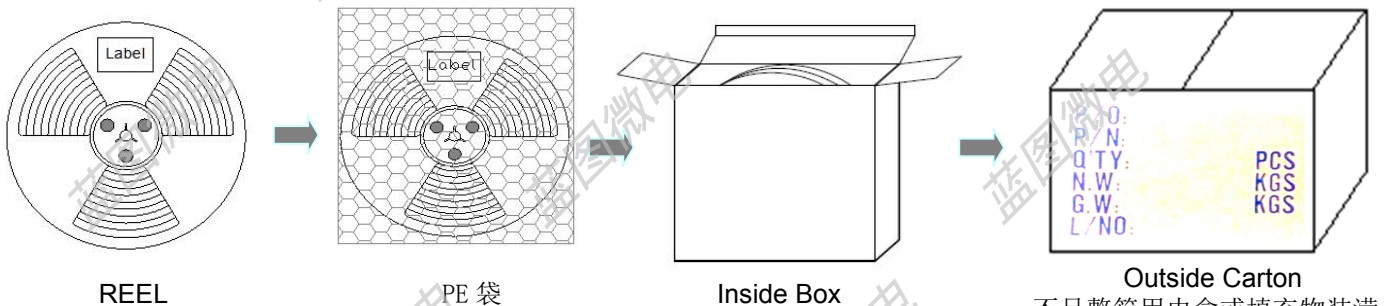


a) Cover tape peel force shall be 10 to 120g

b) Noodle strip peeling angle 165° to 180°

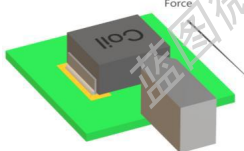

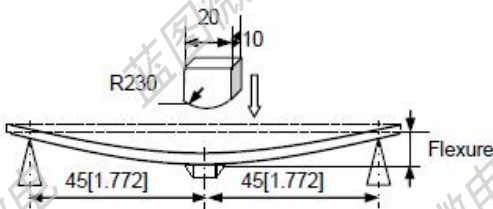


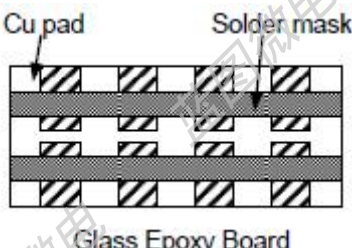
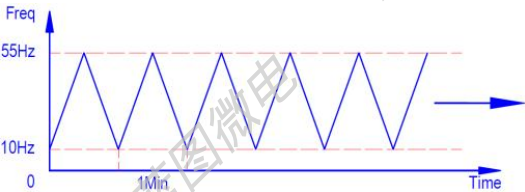
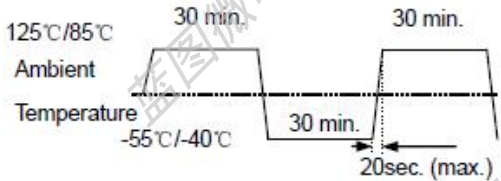
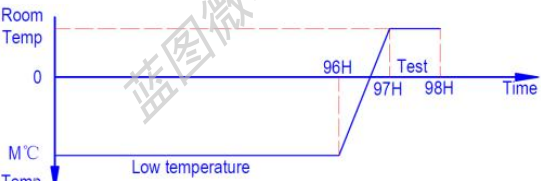
● Packing quantity

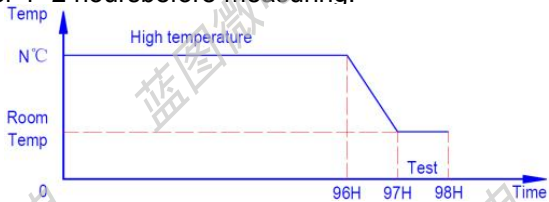
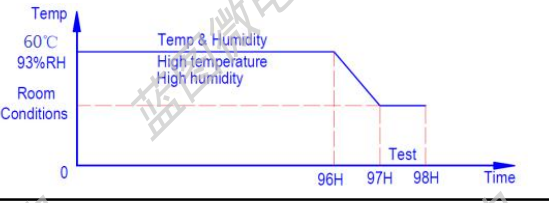


◆可靠性测试:

Reliability Testing:

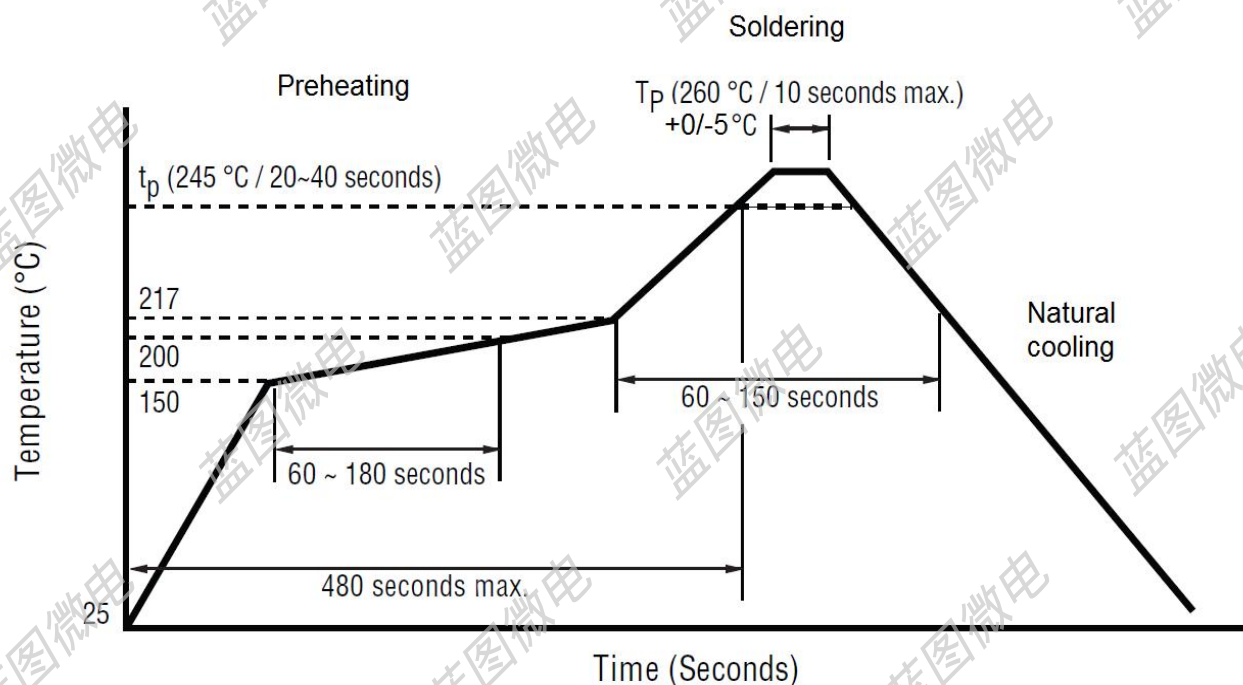
Items	Requirements	Test Methods and Remarks
Terminal Strength Reference documents: GB/T 2423.60-2008 端子强度(SMT)	1. Pulling test: Define: A: sectional area of terminal $A \leq 8\text{mm}^2$ force $\geq 5\text{N}$ time: 30sec $8\text{mm}^2 < A \leq 20\text{mm}^2$ force $\geq 10\text{N}$ time: 10sec $20\text{mm}^2 < A$ force $\geq 20\text{N}$ time: 10sec 2. Solder paste thickness: 0.12mm 3. Meet the above requirements without any loose terminal	Solder the inductor to the testing jig using leadfree solder. Then apply a force in the Keep time: $10 \pm 1\text{s}$ Speed: 1.0mm/s. 
Terminal Strength Reference documents: GB/T 2423.60-2008 端子强度(DIP)	1. Terminal diameter(d) mm $0.35 < d \leq 0.50$ Applied force: 5N Duration: 10sec 2. Terminal diameter(d) mm $0.50 < d \leq 0.80$ Applied force: 10N Duration: 10sec 3. Terminal diameter(d) mm $0.80 < d \leq 1.25$ Applied force: 20N Duration: 10sec 4. Terminal diameter(d) mm $D > 1.25$ Applied force: 40N Duration: 10sec 5. Meet the above requirements without any loose terminal.	Pull Force: the force shall be applied gradually to the terminal and then maintained for 10 seconds. 
Resistance to Flexure JIS C 5321:1997 抗弯曲性试验	1. No visible mechanical damage.	1. Solder the inductor to the test jig (glass epoxy board) 2. shown in Using a leadfree solder. Then apply a force in the direction shown 3. Flexure: 2mm. 4. Pressurizing Speed: 0.5mm/sec. 5. Keep time: 30 sec. 
Dropping Reference documents: GB/T 2423.7-2018 落下试验	1. No case deformation or change in appearance. 2. No short and no open.	1. Drop the packaged products from 1m high in 1 angle, 3 ridges and 6 surfaces, twice in each direction.
Solderability Reference documents: GB/T 2423.28-2005 可焊性试验	1. No visible mechanical damage. 2. Wetting shall exceed 75% coverage for 3. Terminals must have 95% minimum solder coverage	1. Solder temperature: $240 \pm 2^\circ\text{C}$ 2. Duration: 3 sec. 3. Solder: Sn/3.0Ag/0.5Cu. 4. Flux: 25% Resin and 75% ethanol in weight

Items	Requirements	Test Methods and Remarks
<p>Vibration</p> <p>Reference documents: GB/T 2423.10-2019</p> <p>振動試驗</p>	<p>1.No visible mechanical damage.</p> <p>2. Inductance change: Within $\pm 10\%$.</p> <p>3.Q factor change: Within $\pm 20\%$.</p> 	<p>1.Solder the inductor to the testing jig (glass epoxy board shown in) using leadfree solder.</p> <p>2.The inductor shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz.</p> <p>3.The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours).</p> 
<p>Thermal Shock</p> <p>Reference documents: GB/T 2423.22-2012</p> <p>Method Na</p> <p>冷热冲击试验</p>	<p>1.No visible mechanical damage.</p> <p>2. Inductance change: Within $\pm 10\%$. (Mn-Zn: Within $\leq 30\%$)</p> <p>3.Q factor change: Within $\pm 20\%$.</p>	<p>1.Start at (85~125℃) for T time, rush to (-55~-40℃) for T time as one cycle, go through 100 cycles.</p> <p>2.Transforming interval: Max. 20 sec.</p> <p>3.Tested cycle: 100 cycles.</p> <p>4.The chip shall be stabilized at normal condition for 1~2 hours</p> 
<p>Low temperature Storage</p> <p>Reference documents: GB/T 2423.1-2008</p> <p>Method Ab</p> <p>低温储存试验</p>	<p>1.No visible mechanical damage.</p> <p>2. Inductance change: Within $\pm 10\%$. (Mn-Zn: Within $\leq 30\%$)</p> <p>3.Q factor change: Within $\pm 20\%$.</p>	<p>1.Temperature: M(-55~-40$\pm 2^{\circ}\text{C}$)</p> <p>2.Duration: 96± 2 hours</p> <p>3.The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> 

Items	Requirements	Test Methods and Remarks
<p>High temperature Storage</p> <p>Reference documents: GB/T 2423.2-2008</p> <p>Method Bb</p> <p>高温储存试验</p>	<p>1.No visible mechanical damage.</p> <p>2. Inductance change: Within $\pm 10\%$. (Mn-Zn: Within $\leq 30\%$)</p> <p>3.Q factor change: Within $\pm 20\%$.</p>	<p>1.Temperature: $N(125 \sim 85 \pm 2^\circ\text{C})$.</p> <p>2.Duration: 96 ± 2 hours</p> <p>3.The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> 
<p>Damp Heat (Steady States)</p> <p>Reference documents: GB/T 2423.3-2016</p> <p>恒定湿热试验</p>	<p>1.No visible mechanical damage.</p> <p>2. Inductance change: Within $\pm 10\%$. (Mn-Zn: Within $\leq 30\%$)</p> <p>3.Q factor change: Within $\pm 20\%$.</p>	<p>1.Temperature: $60 \pm 2^\circ\text{C}$</p> <p>2.Humidity: 90% to 95% RH.</p> <p>3.Duration: 96 ± 2 hours.</p> <p>4.The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> 
<p>Heat endurance of Reflow soldering</p> <p>Reference documents: GJB 360B-2009</p> <p>回流焊耐热性试验</p>	<p>1.No significant defects in appearance.</p> <p>2. $\Delta L/L \leq 10\%$ (Mn-Zn: $\Delta L/L \leq 30\%$)</p> <p>3. $\Delta Q/Q \leq 30\%$ (SMD series only)</p> <p>4. $\Delta DCR/DCR \leq 10\%$</p>	<p>1. Refer to the above reflow curve and go through the reflow for twice.</p> <p>2.The peak temperature : $260 \pm 0/-5^\circ\text{C}$</p>
<p>Resistance to solvent test</p> <p>Reference documents: IEC 68-2-45:1993</p> <p>耐溶剂性试验</p>	<p>No case deformation or change in appearance or obliteration of marking</p>	<p>To dip parts into IPA solvent for 5 ± 0.5 Min, then drying them at room temp for 5 Min, at last ,to brushing making 10 times.</p>
<p>Overload test</p> <p>Reference documents: JIS C5311-6.13</p> <p>过负荷试验</p>	<p>1.During the test no smoke, no peculiar, smell, no fire</p> <p>2.The characteristic is normal after test</p>	<p>Apply twice as rated current for 5 minutes.</p>
<p>voltage resistance test</p> <p>Reference documents: MIL-STD-202G Method 301</p> <p>绝缘耐压测试</p>	<p>1.During the test no breakdown</p> <p>2.The characteristic is normal after test</p>	<p>1. For parts with two coils</p> <p>2. DC1000V, Current: 1mA, Time: 1Min.</p> <p>3. Refer to catalogue of specific products</p>

◆推荐回流焊温度曲线

Recommended reflow soldering curve:



The recommended reflow conditions as above graph, is set according to our soldering equipment. DUE to various manufactures may have different reflow soldering equipment, products, process conditions, set methods. And so on, when setting the reflow conditions, Please adjust and confirm according to users' environment/equipment.

使用注意事项

REMINDERS FOR USING THESE PRODUCTS



- 保存时间为12 个月以内，保存条件（温度5~40℃以下、湿度35 ~ 66%RH 以下），需充分注意。
若超过保存时间，端子电极的可焊性将可能老化。

The storage period is within 12 months. Be sure to follow the storage conditions (temperature: 5~40°C, humidity: 35 to 65% RH or less). If the storage period elapses, the soldering of the terminal electrodes may deteriorate.

- 请勿在气体腐蚀环境（盐、酸、碱等）下使用和保存。

Do not use or store in locations where there are conditions such as gas corrosion (salt, acid, alkali, etc.).

- 手上的油脂会导致可焊性降低，应避免用手直接接触端子。

Don't touch electrodes directly with bare hands as oil secretions may inhibit soldering. Always ensure optimum conditions for soldering.

- 请小心轻拿轻放,避免由于产品的跌落或取出不当而导致的损坏。

Please always handle products carefully to prevent any damage caused by dropping down or inappropriate removing.

- 端子过度弯曲会导致断线,请不要过度弯曲端子。

Don't bend the terminals with excessive stress in case of any wire fracture.

- 不要清洗产品，如需要清洗时请联系我司。

Don't rinse coils by yourself and please contact SXN if necessary.

- 请勿将本产品靠近磁铁或带有磁力的物体

Don't expose the products to magnets or magnetic fields

- 在实施焊接前，请务必进行预热。预热温度与焊接温度及芯片温度的温度差要在150℃ 以内。

Before soldering, be sure to preheat components. The preheating temperature should be set so that the temperature difference between the solder temperature and chip temperature does not exceed 150°C.

- 安装后的焊接修正应在规格书规定的条件范围内。若加热过度可能导致短路、性能降低、寿命减少。

Soldering corrections after mounting should be within the range of the conditions determined in the specifications. If overheated, a short circuit, performance deterioration, or lifespan shortening may occur.

- 装置会因通电而自我发热（温度上升），因此在热设计方面需留有充分余地。

Self heating (temperature increase) occurs when the power is turned ON, so the tolerance should be sufficient for the set thermal design.

- 非磁屏蔽型在基板设计时需注意配置线圈，受到电磁干扰可能会导致误动作。

Carefully lay out the coil for the circuit board design of the non-magnetic shield type. A malfunction may occur due to magnetic interference.